Used in Lieu of PTO/SB/08A/B OCT 1 2 2007 (Based on PTO 10-07 version) Complete if Known PARENT for form 1449/PTO **Application Number** 10/812,155-Conf. #2941 INFORMATION DISCLOSURE Filing Date March 29, 2004 Keisuke Inoue STATEMENT BY APPLICANT First Named Inventor 2116 Art Unit (Use as many sheets as necessary) Examiner Name S. Stoynov SCEI 3.0-200 Sheet Attorney Docket Number

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Examiner Initials*	Cite No.1	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear					
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NON PATENT LITERATURE DOCUMENTS							
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²				
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